RF EXPOSURE REPORT FOR CERTIFICATION On Behalf of

mophie LLC

mophie snap+ stand & pad

Model Number: SNP-STND-PAD

FCC ID: 2ACWB-STNDPAD

Applicant:	Applicant: mophie LLC			
Address:	6244 Technology Ave. Kalamazoo, MI 49009, United States of America.			
Prepared By:	d By: EST Technology Co., Ltd.			
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Report Number:	ESTE-R2206199
Date of Test:	Jun. 14~Jun. 22, 2022
Date of Report:	Jun. 23, 2022

EST Technology Co., Ltd Report No. ESTE-R2206199

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EST Technology Co., Ltd.

Applicant: mophie LLC

6244 Technology Ave. Kalamazoo, MI 49009, United States of America. **Address:**

Manufacturer: mophie LLC

Address: 6244 Technology Ave. Kalamazoo, MI 49009, United States of America.

E.U.T: mophie snap+ stand & pad

Model Number: SNP-STND-PAD

Input: 12V = -3.5A**Power Supply:** Output(Stand): 15W

Output(Pad): 5W

Trade Name: Serial No.: mophie

Date of Receipt: May. 26, 2022 Date of Test: Jun. 14~Jun. 22, 2022

FCC CFR 47 Part 1.1307(b)&1.1310 **Test Specification:**

KDB 680106 D01 RF Exposure Wireless Charging Apps v03r01

Test Result: The device described above is tested by EST Technology Co., Ltd. The

> measurement results were contained in this test report and EST Technology Co., Ltd. was assumed full responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT to be technically compliance with the FCC CFR 47 Part 1.1307(b)&1.1310 requirements. This report applies to above tested sample only and shall not be reproduced in part without wri

approval of EST Technology Co., Ltd.

Date: Jun. 23,26

Iceman Hu / Manager

Approved by: Prepared by: Reviewed by:

Seven Wang / Engineer

Other Aspects:

Ring Yang / Assistant

None.

Abbreviations: OK/P=passed *n.a/N=not applicable* fail/F=failed E.U.T=equipment under tested

This test report is based on a single evaluation of one sample of above mentioned products, It is not permitted to be duplicated in extracts without written approval of EST Technology Co., Ltd.

1. SUMMARY OF TEST

1.1. Summary of test result

Serial Number	Description of Test Item	FCC Standard Section	Results
1	Maximum Permissible Exposure	Part 1.1307(b)&1.1310	PASS

1.2. Test Mode

Test Item	Test Mode	
	Wireless Charging with Empty Load	
Maximum Permissible Exposure	Wireless Charging with Half Load	
	Wireless Charging with Full Load	
Note: The worst Full Load status is recorded in the report		

1.3. Test Equipment List

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Electric and Magnetic Field	Narda	EHP-200A	EST-E106	Juna 12 22	1 Year
Probe-Analyzer	S.T.S./PMM	EHF-200A	E31-E100	Julie 13,22	1 Teal
Simulated load	/	/	EST-306	N/A	N/A
Simulated load	/	/	EST-307	N/A	N/A
Test Software	Narda	EHP200-TS	Rel 1.92	N/A	N/A

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2. MAXIMUM PERMISSIBLE EXPOSURE

2.1. Limit

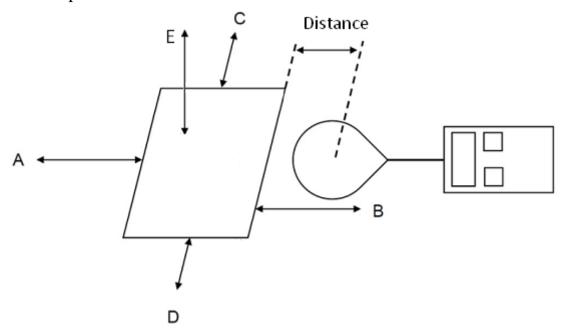
Limits for Maximum Permissible Exposure (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm2)	Averaging time (minutes)	
	(A) Limits for Occupational/Controlled Exposure				
0.3-3.0	614	1.63	*100	6	
3.0-30	1842/f	4.89/f	$*900/f^2$	6	
30-300	61.4	0.163	1.0	6	
300-1,500			f/300	6	
1,500-100,000			5	6	
	(B) Limits for General Population/Uncontrolled Exposure				
0.3-1.34	614	1.63	*100	30	
1.34-30	824/f	2.19/f	$*180/f^{2}$	30	
30-300	27.5	0.073	0.2	30	
300-1,500			f/1500	30	
1,500-100,000			1.0	30	

Note:

- 1. f = frequency in MHz * = Plane-wave equivalent power density.
- 2. For devices designed for typical desktop applications, such a wireless charging pads, RF exposure evaluation should be conducted assuming a user separation distance of 15 cm. E and H field strength measurements or numerical modeling may be used to demonstrate compliance. Measurements should be made from all sides and the top of the primary/client pair, with the 15 cm measured from the center of the probe(s) to the edge of the device. Emissions between 100 kHz to 300 kHz should be assessed versus the limits at 300 kHz in Table 1 of Section 1.1310: 614 V/m and 1.63 A/m. A KDB inquiry is required to determine the applicable exposure limits below 100 kHz.

2.2. Test Setup A



2.3. Test Procedure

- a. The test was performed on 360 degree turn table in anechoic chamber.
- b. The probe was placed at 15 cm surrounding the device and 20 cm above the top of the charger and the geometric centre of the probe, for test setup A.
- d. The highest emission level was recorded and compared with limit as soon as measurement of each point; A, B, C, D, E were completed.

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2.4. Equipment Approval Considerations

Inductive wireless power transfer applications with supporting field strength results and meeting all of the following requirements are not required to submit a KDB inquiry for devices approved using SDoC or a PAG for equipment approved using certification to address RF exposure compliance.

1	Power transfer frequency is less that 1 MHz		
1	YES; the device operated in the frequency range from 110.5-205KHz.		
2	Output power from each primary coil is less than or equal to 15 watts.		
2	NO; Output(Stand):15W;Output(Pad):5W.		
	The system may consist of more than one source primary coils, charging one or more		
3	clients. If more than one primary coil is present, the coil pairs may be powered on at		
3	the same time.		
YES; the transfer system includes only single primary and secondary coils.			
4	Client device is placed directly in contact with the transmitter.		
4	YES; Client device is placed directly in contact with the transmitter.		
	Mobile exposure conditions only (portable exposure conditions are not covered by		
5	this exclusion).		
	YES.		
	The aggregate H-field strengths at 15 cm surrounding the device and 20 cm above the		
_	top surface from all simultaneous transmitting coils are demonstrated to be less than		
6	50% of the MPE limit.		
	YES; The EUT field strength levels are 50% x MPE limts.		

2.5. Test Result for Test setup A:

E-field strength		
Frequency range (KHz)	110.5 to 205	
Test Mode	Full Load	
Position A(V/m)	1.321	
Position B(V/m)	1.521	
Position C(V/m)	1.442	
Position D(V/m)	1.212	
Position E(V/m)	7.829	
Limits (V/m)	614	
50% Limits(V/m)	307	

	H-field strength
Frequency range (KHz)	110.5 to 205
Test Mode	Full Load
Position A(A/m)	0.034
Position B(A/m)	0.056
Position C(A/m)	0.048
Position D(A/m)	0.041
Position E(A/m)	0.132
Limits (A/m)	1.630
50% Limits (A/m)	0.815

3. TEST SETUP PHOTO

Position E Stand



Pad



End of Test Report



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